Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/027,488	NEEDHAM ET AL.	
Examiner	Art Unit	
Thien D. Tran	2665	

	SEARCHED				
Class	Subclass	Date	Examiner		
370	331	5/8/2005	тт		
	332	5/8/2005	тт		
	333	5/8/2005	тт		
	334	5/8/2005	тт		
455	442	5/8/2005	тт		
	443	5/8/2005	TT		
	444	5/8/2005	TT		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEA	I NOTES RCH STRATEGY	·)
	DATE	EXMR
East	5/8/2005	п.
East	5/8/2005	т
East	5/8/2005	т